



Based on Form PT-449 (3/90)	ATTY. DOCKET NO. 450100-03059	SERIAL NO. 09/804,434
	APPLICANT Teruhiko SUZUKI et al.	
	FILING DATE March 12, 2001	GROUP 2857

LIST OF REFERENCES CITED BY APPLICANT
(Use several sheets if necessary)

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>csf</i> X	AA	6,408,350	6/18/02	Kawamura et al.			
	AB						
	AC						
	AD						
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	AG						
	AH						
	AI						
	AJ						
	AK						

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FOREIGN PATENT DOCUMENTS

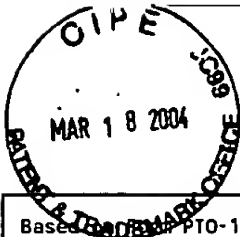
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
<i>csf</i> X	AL	0 924 933	6/23/99	EP			
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OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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Based on PTO-1449 (3/90)	ATTY. DOCKET NO. 450100-03059	SERIAL NO. 09/804,434
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U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>ef</i>	AA	US 6031872	02/29/00	Han			
<i>ef</i>	AB	US 5963222	10/05/99	Cheney et al.			
<i>ef</i>	AC	US 5594495	01/14/97	Palmer et al.			
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
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	AP						

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EXAMINER <i>[Signature]</i>	DATE CONSIDERED <i>5/19/04</i>
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